

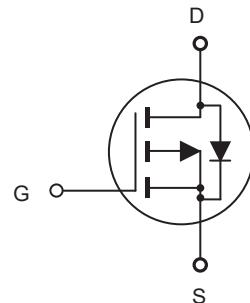


CED30P10A/CEU30P10A

P-Channel Enhancement Mode Field Effect Transistor

FEATURES

- -100V, -29A, $R_{DS(ON)} = 55\text{ m}\Omega$ @ $V_{GS} = -10\text{ V}$.
 $R_{DS(ON)} = 60\text{ m}\Omega$ @ $V_{GS} = -4.5\text{ V}$.
- Super high dense cell design for extremely low $R_{DS(ON)}$.
- High power and current handing capability.
- Pb-free lead plating ; RoHS compliant.
- Halogen Free.
- TO-251 & TO-252 package.



Applications

- Switched mode power supplies.
- Lighting.
- DC Motor control.
- Load switch.
- battery powered.



ABSOLUTE MAXIMUM RATINGS

 $T_C = 25^\circ\text{C}$ unless otherwise noted

| Parameter | Symbol | Limit | Units |
|---|----------------|--------------|--------------------------|
| Drain-Source Voltage | V_{DS} | -100 | V |
| Gate-Source Voltage | V_{GS} | ± 20 | V |
| Drain Current-Continuous @ $T_C = 25^\circ\text{C}$ @ $T_C = 100^\circ\text{C}$ | I_D | -29 -20 | A |
| Drain Current-Pulsed ^a | I_{DM} | -116 | A |
| Maximum Power Dissipation @ $T_C = 25^\circ\text{C}$ - Derate above 25°C | P_D | 83.3 0.55 | W W/ $^\circ\text{C}$ |
| Single Pulsed Avalanche Energy ^d | E_{AS} | 200 | mJ |
| Single Pulsed Avalanche Current ^d | I_{AS} | 20 | A |
| Operating and Store Temperature Range | T_J, T_{stg} | -55 to 175 | $^\circ\text{C}$ |

Thermal Characteristics

| Parameter | Symbol | Limit | Units |
|---|-----------------|-------|--------------------|
| Thermal Resistance, Junction-to-Case | $R_{\theta JC}$ | 1.8 | $^\circ\text{C/W}$ |
| Thermal Resistance, Junction-to-Ambient | $R_{\theta JA}$ | 50 | $^\circ\text{C/W}$ |



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Electrical Characteristics $T_C = 25^\circ\text{C}$ unless otherwise noted

| Parameter | Symbol | Test Condition | Min | Typ | Max | Units |
|---|----------------------------|---|------|------|------|------------------|
| Off Characteristics | | | | | | |
| Drain-Source Breakdown Voltage | BV_{DSS} | $V_{\text{GS}} = 0\text{V}, I_D = -250\mu\text{A}$ | -100 | | | V |
| Zero Gate Voltage Drain Current | I_{DSS} | $V_{\text{DS}} = -100\text{V}, V_{\text{GS}} = 0\text{V}$ | | | -1 | μA |
| Gate Body Leakage Current, Forward | I_{GSSF} | $V_{\text{GS}} = 20\text{V}, V_{\text{DS}} = 0\text{V}$ | | | 100 | nA |
| Gate Body Leakage Current, Reverse | I_{GSSR} | $V_{\text{GS}} = -20\text{V}, V_{\text{DS}} = 0\text{V}$ | | | -100 | nA |
| On Characteristics^b | | | | | | |
| Gate Threshold Voltage | $V_{\text{GS}(\text{th})}$ | $V_{\text{GS}} = V_{\text{DS}}, I_D = -250\mu\text{A}$ | -1 | | -3 | V |
| Static Drain-Source On-Resistance | $R_{\text{DS}(\text{on})}$ | $V_{\text{GS}} = -10\text{V}, I_D = -16\text{A}$ | | 44 | 55 | $\text{m}\Omega$ |
| | | $V_{\text{GS}} = -4.5\text{V}, I_D = -8\text{A}$ | | 48 | 60 | $\text{m}\Omega$ |
| Dynamic Characteristics^c | | | | | | |
| Input Capacitance | C_{iss} | $V_{\text{DS}} = -25\text{V}, V_{\text{GS}} = 0\text{V}, f = 1.0 \text{ MHz}$ | | 4340 | | pF |
| Output Capacitance | C_{oss} | | | 215 | | pF |
| Reverse Transfer Capacitance | C_{rss} | | | 175 | | pF |
| Switching Characteristics^c | | | | | | |
| Turn-On Delay Time | $t_{\text{d}(\text{on})}$ | $V_{\text{DD}} = -50\text{V}, I_D = -18\text{A}, V_{\text{GS}} = -10\text{V}, R_{\text{GEN}} = 3.3\Omega$ | | 20 | | ns |
| Turn-On Rise Time | t_r | | | 9 | | ns |
| Turn-Off Delay Time | $t_{\text{d}(\text{off})}$ | | | 85 | | ns |
| Turn-Off Fall Time | t_f | | | 17 | | ns |
| Total Gate Charge | Q_g | $V_{\text{DS}} = -80\text{V}, I_D = -18\text{A}, V_{\text{GS}} = -4.5\text{V}$ | | 44 | | nC |
| Gate-Source Charge | Q_{gs} | | | 8 | | nC |
| Gate-Drain Charge | Q_{gd} | | | 22 | | nC |
| Drain-Source Diode Characteristics and Maximum Ratings | | | | | | |
| Drain-Source Diode Forward Current | I_S | | | | -29 | A |
| Drain-Source Diode Forward Voltage ^b | V_{SD} | $V_{\text{GS}} = 0\text{V}, I_S = -16\text{A}$ | | | -1.2 | V |

Notes :

- a.Repetitive Rating : Pulse width limited by maximum junction temperature.
- b.Pulse Test : Pulse Width $\leq 300\mu\text{s}$. Duty Cycle $\leq 2\%$.
- c.Guaranteed by design, not subject to production testing.

d.L = 1mH, $I_{AS} = 20\text{A}$, $V_{PD} = 25\text{V}$, $R_G = 25\Omega$, Starting $T_J = 25^\circ\text{C}$.

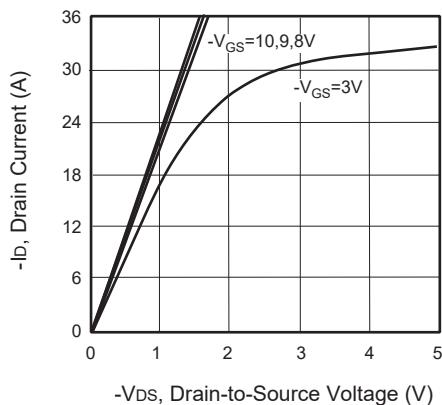


Figure 1. Output Characteristics

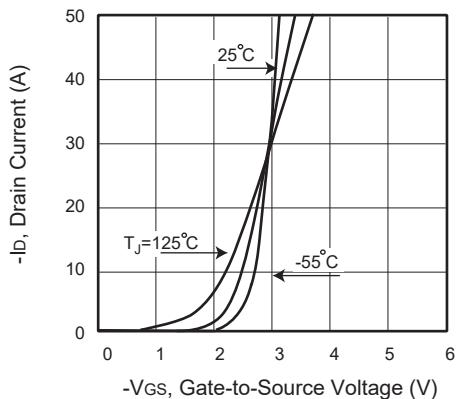


Figure 2. Transfer Characteristics

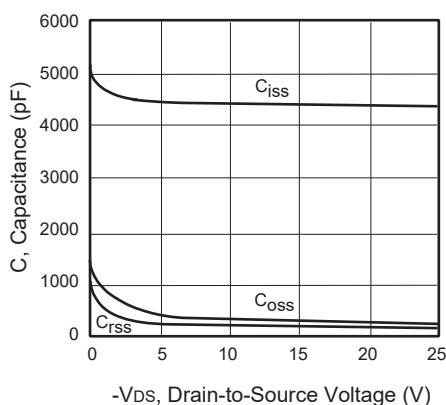


Figure 3. Capacitance

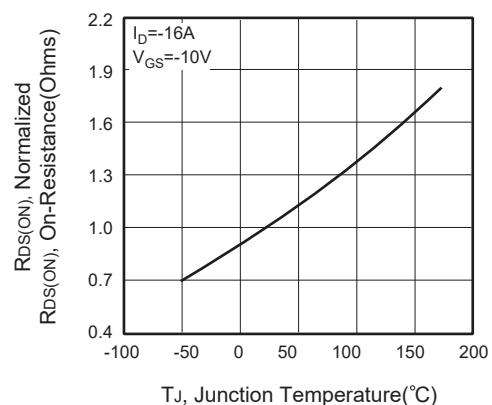


Figure 4. On-Resistance Variation with Temperature

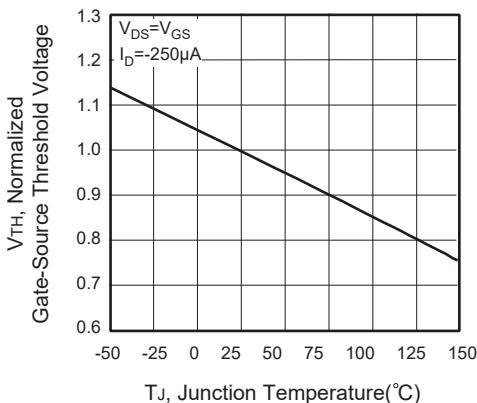


Figure 5. Gate Threshold Variation with Temperature

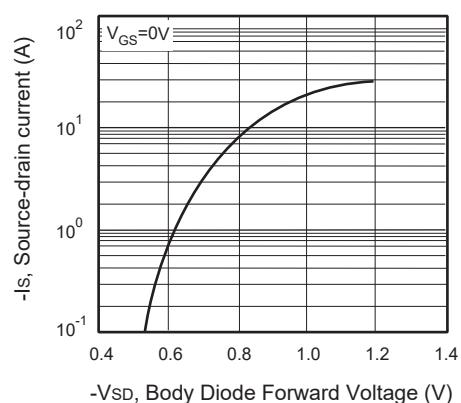


Figure 6. Body Diode Forward Voltage Variation with Source Current



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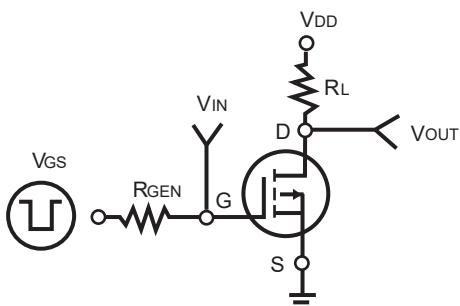
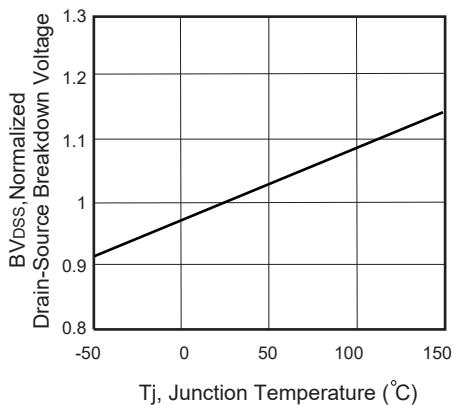
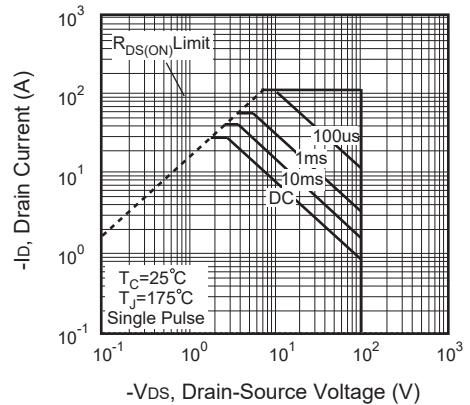
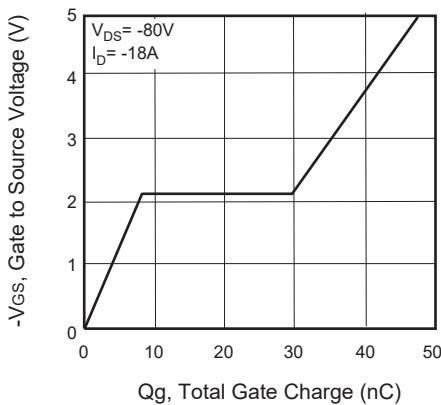
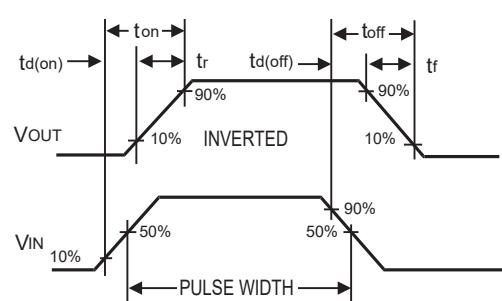


Figure 10. Switching Test Circuit





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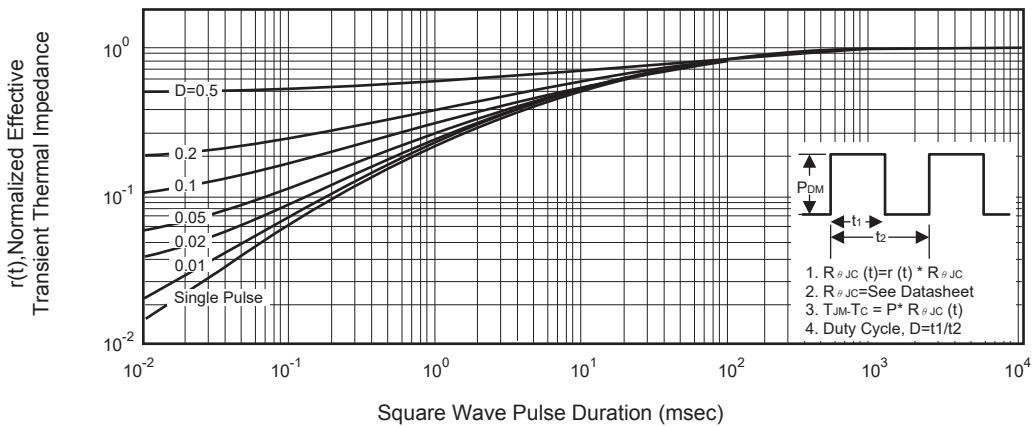


Figure 12. Normalized Thermal Transient Impedance Curve